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Contents

V	Δ	11+	hr	ors
V	А	UΙ	ш	JI 5

vii Conference Committee

SESSION 1	NOVEL PATTERN RECOGNITION AND TRACKING
10203 02	Contemporary deep recurrent learning for recognition (Invited Paper) [10203-1]
10203 03	Intelligent multi-spectral IR image segmentation (Invited Paper) [10203-2]
10203 05	Comparative analysis of zero aliasing logarithmic mapped optimal trade-off correlation
10200 00	filter [10203-4]
10203 06	Feature extraction for deep neural networks based on decision boundaries [10203-6]
SESSION 2	INVARIANT RECOGNITION
3L331ON 2	INVARIANT RECOGNITION
10203 07	Fully invariant wavelet enhanced minimum average correlation energy filter for object recognition in cluttered and occluded environments [10203-8]
10203 08	Wavelet filtered shifted phase-encoded joint transform correlation for face recognition [10203-9]
10203 09	Multispectral iris recognition based on group selection and game theory [10203-10]
10203 0A	Phase conjugate Michelson interferometer for optical logic [10203-11]
SESSION 3	UNCONVENTIONAL PATTERN RECOGNITION TECHNIQUES
10203 0C	Point based interactive image segmentation using multiquadrics splines [10203-12]
10203 0D	Utilization of the modified forward backward linear predication approach to isolate anomalous events [10203-13]
10203 0E	Time-to-impact estimation in passive missile warning systems [10203-15]
10203 OF	Compressed imagery detection rate through map seeking circuit, and histogram of oriented gradient pattern recognition [10203-16]

SESSION 4	BIOMETRIC RECOGNITION
10203 0G	2D DOST based local phase pattern for face recognition [10203-18]
10203 0H	Multi-texture local ternary pattern for face recognition [10203-19]
10203 OJ	All optical logic for optical pattern recognition and networking applications [10203-21]
SESSION 5	IMPLEMENTATION FOR PATTERN RECOGNITION
10203 0M	Rapid prototyping of SoC-based real-time vision system: application to image preprocessing and face detection [10203-24]
10203 0N	FPGA design of correlation-based pattern recognition [10203-25]
10203 00	Graph clustering for weapon discharge event detection and tracking in infrared imagery using deep features (Invited Paper) [10203-28]
	POSTER SESSION
10203 OP	Image encryption with chaotic map and Arnold transform in the gyrator transform domains [10203-26]
10203 0Q	Comparison of sub-scaled to full-scaled aircrafts in simulation environment for air traffic management [10203-27]

Authors

Numbers in the index correspond to the last two digits of the seven-digit citation identifier (CID) article numbering system used in Proceedings of SPIE. The first five digits reflect the volume number. Base 36 numbering is employed for the last two digits and indicates the order of articles within the volume. Numbers start with 00, 01, 02, 03, 04, 05, 06, 07, 08, 09, 0A, 0B...0Z, followed by 10-1Z, 20-2Z, etc.

Abbas, Muhammad, 05 Ahmad, Foysal, 09 Alam, M., 02 Alam, Mohammad S., 07, 08, 0G, 0P Alfalou, Ayman, 0M, 0N

Bhattacharjee, Sreyasee Das, 00

Bilal, Ahmed, 05 Cai, Bin, OP

Asari, Viiavan, 0H

Chao, Tien-Hsin, 03

Chaudry, Qaiser, 05

Chen, Kang, 03

Chow, Edward, 03

Creusere, Charles C., 0F Duraisamy, Prakash, 0C

Elbakary, Mohamed I., 0Q

Essa, Almabrok, 0H

Hassan, Ali, 07 Heim, Stephen, 03

Iftekharuddin, Khan M., 02, 0Q

Jridi, Maher, 0M, 0N Khan, Muazzam, 07

Khoury, Jed, 0A, 0J

Lee, Chulhee, 06

Lu, Thomas, 03

Luo, Hongling, OP

Luong, Andrew, 03

Meena, Sachin, OC

Moniruzzaman, Md., 08, 0G

Newman, Brett, OQ

Newtson, Kathy A., 0F

Palanniapan, Kannappan, OC

Papelis, Yiannis, 0Q

Patel, Maharshi, 03

Rehman, Saad, 05, 07

Riasati, Vahid R., 0D

Riaz, Farhan, 07

Roy, Kaushik, 09

Saeed, Omer, 05, 07

Şahıngıl, Mehmet Cihan, 0E

Sang, Jun, OP

Seetharaman, Guna, 0C

Shelton, Joseph, 09

Talukder, Ashit, 00

Tehsin, Sara, 05, 07

Torres, Gilbert, 03 Vidyaratne, L., 02 Woo, Seongyoun, 06 Young, Rupert, 05 Zhao, Jun, OP

٧

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